

Application/Control No.	Applicant(s)/Patent under Reexamination
10/539,254	MIYAKE ET AL.
Examiner	Art Unit
Ram N. Kackar	1763

SEARCHED					
Class	Subclass	Date	Examiner		
156	345.48	9/29/2007	RK		
118	723i				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Text search in US and Foreign databases	9/29/2007	RK		
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